

Application/Control No.	Applicant(s)/Patent under Reexamination
10/072,622	CHEN ET AL.
Examiner	Art Unit
ILIA OUSPENSKI	1644

	SEARCHED		
Class	Subclass	Date	Examiner
			, -
	- · = · · ·		
	· · ·		

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Discussed Enablement and New Matter issues with TQAS Y. Eyler	6/29/2006	1.0.	
Sequence search by STIC for I.O.	5/12/2006	1.0.	
WEST: updated	6/30/2006	I.O.	
Inventor search: updated	6/30/2006	I.O.	